

8A 600V N-channel Enhancement Mode Power MOSFET

1 Description

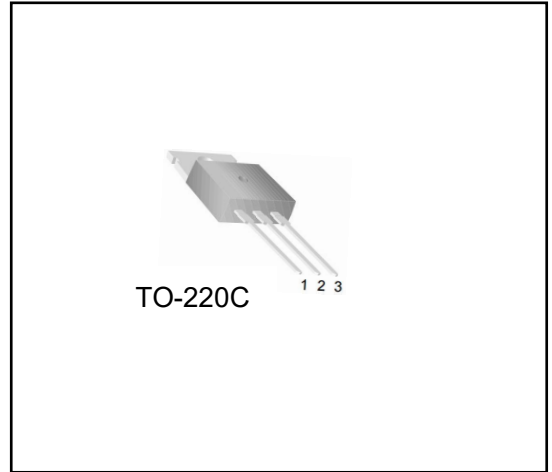
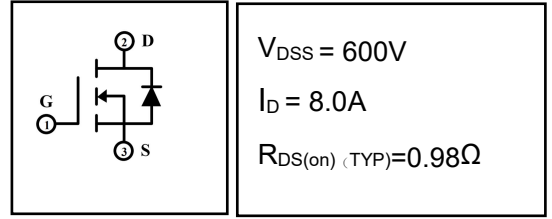
These N-channel enhanced vdmofets, is obtained by the self-aligned planar technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. Which accords with the RoHS standard.

2 Features

- Fast switching
- ESD improved capability
- Low on resistance($R_{dson} \leq 1.2\Omega$)
- Low gate charge(Typ: 24nC)
- Low reverse transfer capacitances(Typ: 5.5pF)
- 100% single pulse avalanche energy test
- 100% ΔV_{DS} test

3 Applications

- Used in various power switching circuit for system miniaturization and higher efficiency.
- Power switch circuit of electron ballast and adaptor.



4 Electrical Characteristics

4.1 Absolute Maximum Ratings (Tc=25°C, unless otherwise noted)

PARAMETER	SYMBOL	VALUE	UNIT
Drain-Source Voltage	V_{DS}	600	V
Gate-Source Voltage	V_{GS}	± 30	V
Drain Current(continuous) ^(Note 3)	I_D	8	A
Drain Current(continuous)(T=100°C) ^(Note 3)	I_D	5	A
Drain Current(Pulsed)	I_{DM}	32	A
Single Pulse Avalanche Energy ^(Note 4)	E_{AS}	450	mJ
Derating Factor above	P_D	2	W
Power Dissipation		100	W
Operating Junction Temperature Range	T_j	-55 ~ 150	°C
Storage Temperature Range	T_{stg}	-55 ~ 150	°C
High Temperature(tin solder)	T_L	300	°C

4.2 Thermal Characteristics

PARAMETER	SYMBOL	VALUE	UNIT
Thermal Resistance, Junction to Case-sink	R_{thJC}	1.25	°C/W
Thermal Resistance, Junction to Ambient	R_{thJA}	62.5	°C/W

4.3 Electrical Characteristics (Tc=25°C, unless otherwise noted)

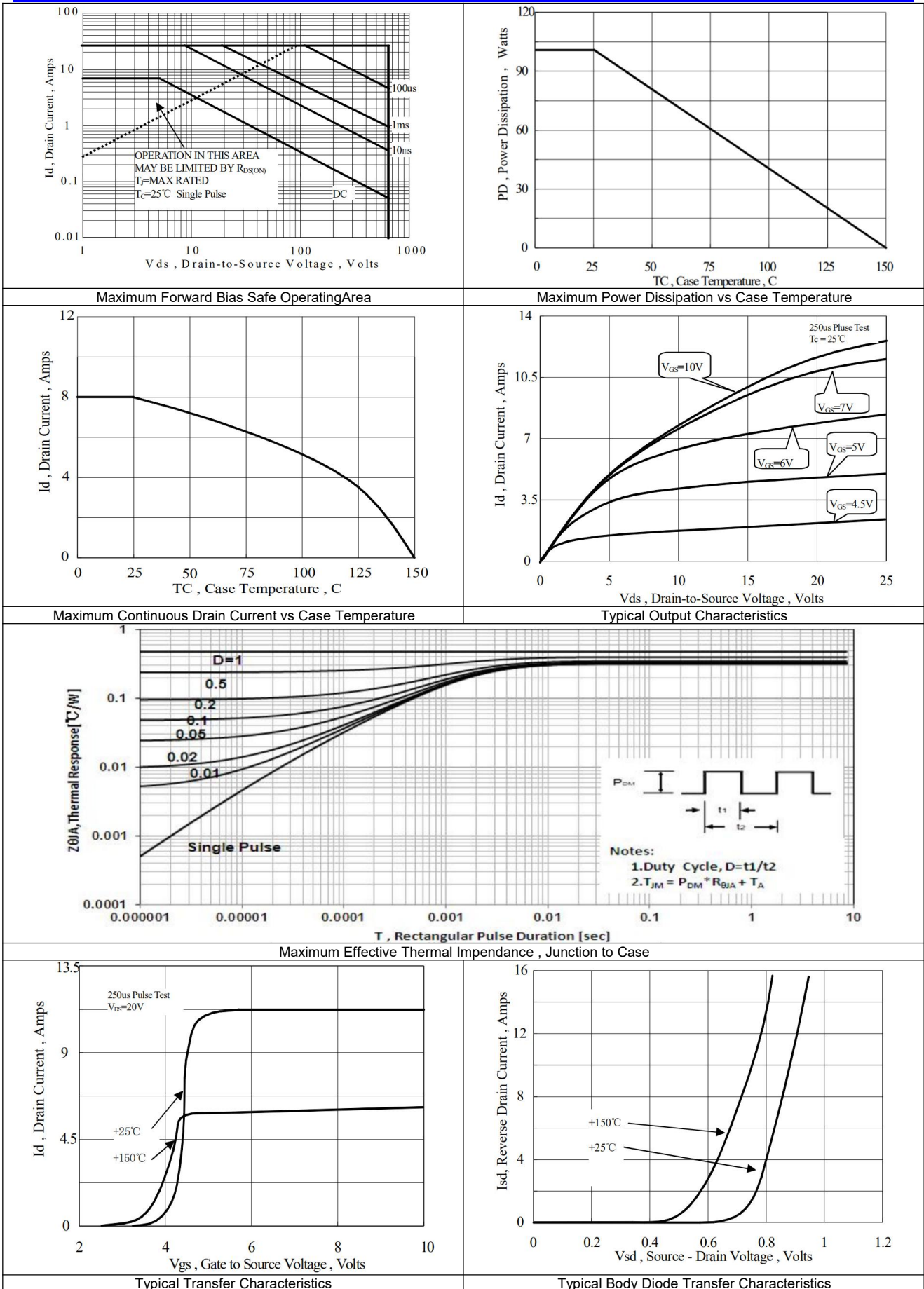
PARAMETER	SYMBOL	Test Condition	VALUE			UNIT
			MIN	TYP	MAX	
Off Characteristics						
Drain-source Breakdown Voltage	BV _{DSS}	I _D =250μA, V _{GS} =0V	600	--	--	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =600V, V _{GS} =0V, T _C =25°C	--	--	1	μA
		V _{DS} =480V, V _{GS} =0V, T _C =125°C	--	--	100	μA
Gate-to-Body Leakage Current	I _{GSS}	V _{GS} =±30V, V _{DS} =0V	--	--	±100	nA
On Characteristics (Note 3)						
Gate threshold voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250μA	2.0	--	4.0	V
Drain-source on Resistance	R _{DS(on)}	V _{GS} =10V, I _D =4.0A	--	0.98	1.2	Ω
Dynamic Characteristics						
Input Capacitance	C _{iss}	V _{GS} =0V, V _{DS} =25V, f=1.0MHz	--	1121	--	pF
Output Capacitance	C _{oss}		--	96	--	
Reverse Transfer Capacitance	C _{rss}		--	5.5	--	
Turn-on Delay Time	T _{d(on)}	I _D =8A, V _{DD} =325V, V _{GS} =10V, R _G =10Ω	--	18	--	ns
Turn-on Rise Time	t _r		--	22	--	
Turn-off Delay Time	T _{d(off)}		--	40	--	
Turn-off Fall	t _f		--	19	--	
Total Gate Charge	Q _g	I _D =8A, V _{DD} =520V, V _{GS} =10V	--	24	--	nC
Gate-to-Source Charge	Q _{gs}		--	4.8	--	
Gate-to-Drain("Miller")C harge	Q _{gd}		--	9.5	--	
Drain-Source Diode Characteristics						
Diode Forward Voltage (Note 3)	V _{FSD}	V _{GS} =0V, I _S =8A	--	--	1.5	V
Continuous Source Current (BodyDiode) (Note 3)	I _S		--	--	8	A
Reverse Recovery Time	trr	T _J =25°C, I _F =8A, dI _F /dt=100A/μS, V _{GS} =0V	--	385	--	ns
Reverse Recovery Charge	Q _{rr}		--	2000	--	nC

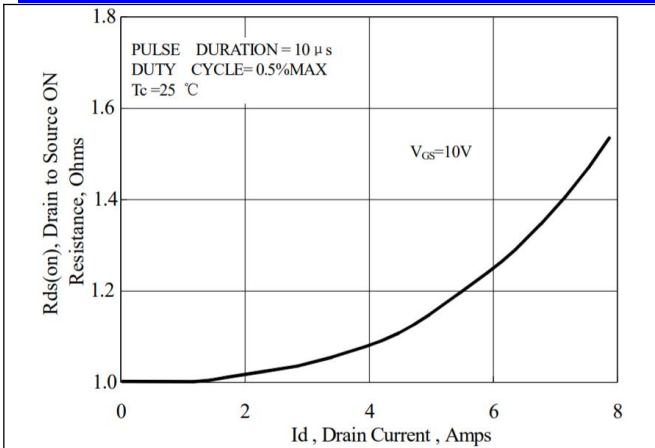
Notes:

- 1: Repetitive rating, pulse width limited by maximum junction temperature.
- 2: Surface mounted on FR4 Board, t≤10sec.
- 3: Pulse width ≤ 300μs, duty cycle ≤ 2%.
- 4: L=10mH, I_D=9.5A, V_{DD}=50V, Start T_J=25°C.

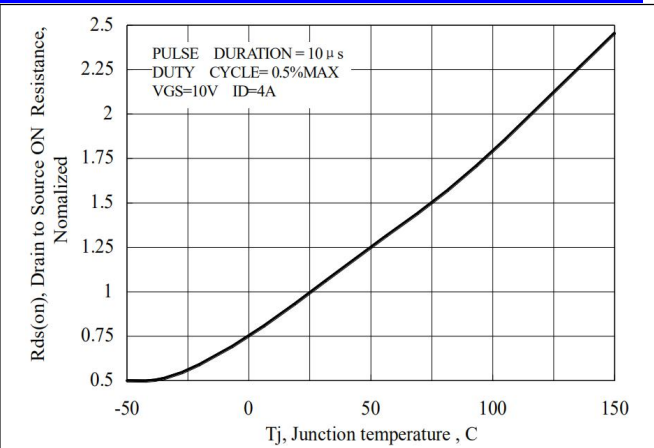
5 Typical Test Circuit and Waveform

<p style="text-align: center;">Gate Charge Test Circuit</p>	<p style="text-align: center;">Gate Charge Waveforms</p>
<p style="text-align: center;">Resistive Switching Test Circuit</p>	<p style="text-align: center;">Resistive Switching Waveforms</p>
<p style="text-align: center;">Diode Reverse Recovery Test Circuit</p>	<p style="text-align: center;">Diode Reverse Recovery Waveform</p> $E_{AS} = \frac{I_{AS}^2 L}{2}$
<p style="text-align: center;">Unclamped Inductive Switching Test Circuit</p>	<p style="text-align: center;">Unclamped Inductive Switching Waveform</p>

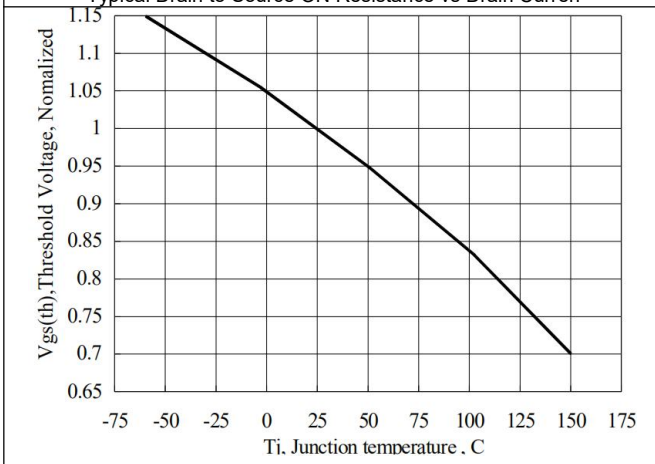




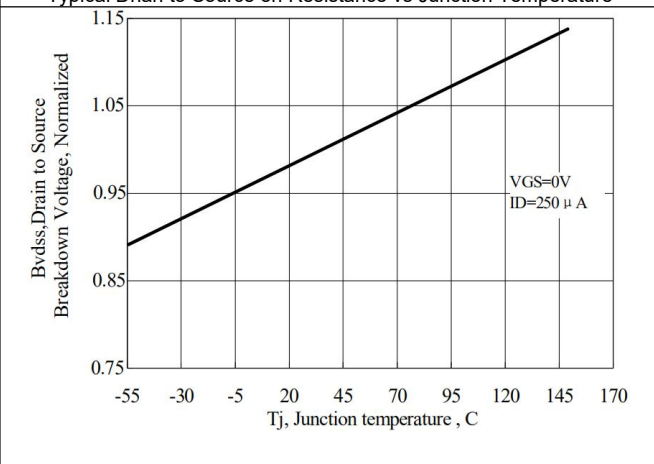
Typical Drain to Source ON Resistance vs Drain Current



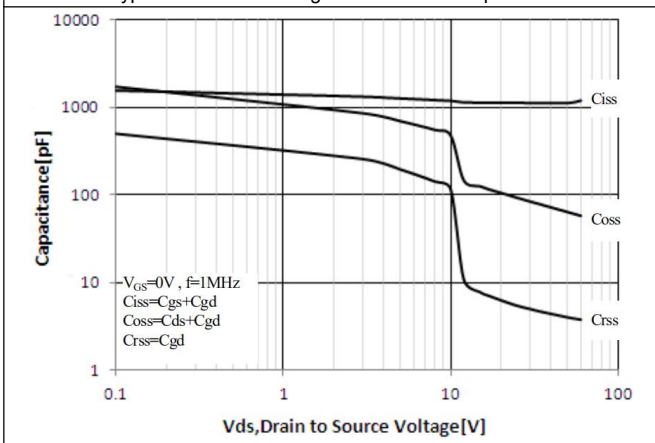
Typical Drain to Source on Resistance vs Junction Temperature



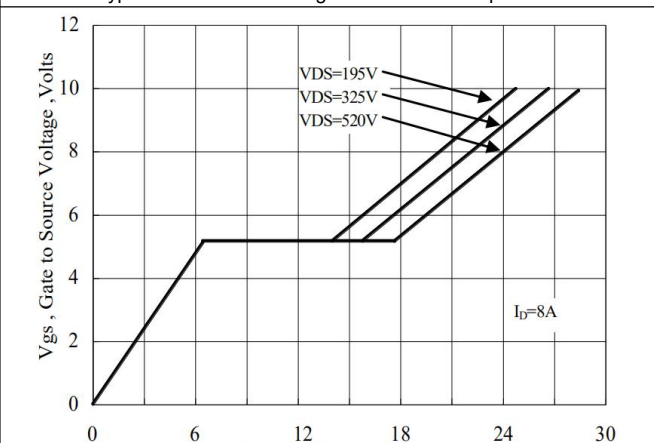
Typical Threshold Voltage vs Junction Temperature



Typical Breakdown Voltage vs Junction Temperature



Typical Capacitance vs Drain to Source Voltage



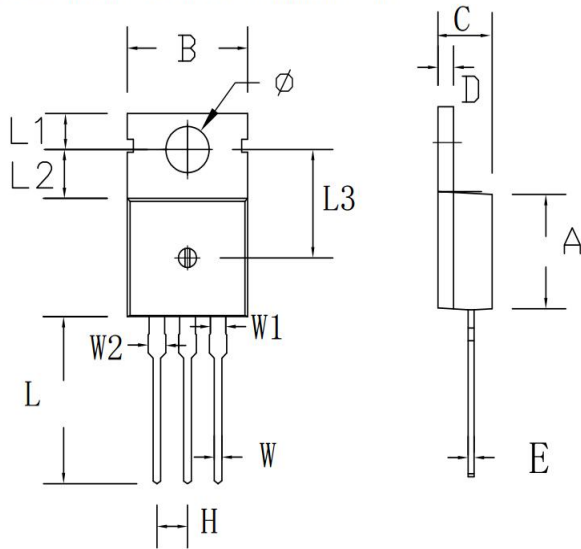
Typical Gate Charge vs Gate to Source Voltage

6 Product Specifications and Packaging Models

Product Model	Package Type	Mark Name	RoHS	Package	Quantity
8N60	TO-220C	8N60	Pb-free	Tube	1000/box

7 Dimensions

TO-220C PACKAGE OUTLINE DIMENSIONS



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	min.	max.	min.	max.
A	8.80	9.30	0.346	0.366
B	9.70	10.30	0.382	0.406
C	4.25	4.75	0.167	0.187
D	1.20	1.45	0.047	0.057
E	0.40	0.60	0.016	0.024
H	2.54 TYP		0.100 TYP	
W	0.60	0.95	0.024	0.037
W1	1.05	1.45	0.041	0.057
W2	1.20	1.60	0.047	0.063
L	12.60	13.40	0.496	0.528
L1	2.45	2.95	0.096	0.116
L2	3.45	3.95	0.136	0.156
L3	8.15	8.65	0.321	0.341
Φ	3.50	3.90	0.138	0.154

8 Attentions

- Jiangsu Donghai Semiconductor Technology Co., Ltd. reserves the right to change the specification without prior notice! The customer should obtain the latest version of the information before making the order and verify that the information is complete and up to date.
- It is the responsibility of the purchaser for any failure or failure of any semiconductor product under certain conditions. It is the responsibility of the purchaser to comply with safety standards and to take safety measures in the system design and machine manufacturing of WXDH products in order to avoid potential risk of failure. Injury or property damage.
- Product promotion is endless, our company will be dedicated to provide customers with better products.

9 Appendix

Revision history:

Date	REV.	Description	Page
2020.03.09	1.0	Original	